Unit in mm

TOSHIBA Photocoupler GaAlAs Ired & Photo-IC

TLP115A

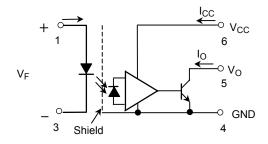
High Speed, Long Distance Isolated Line Receiver Microprocessor System Interfaces
Digital Isolation For A / D, D / A Conversion
Computer-Peripheral Interfaces
Ground Loop Elimination

The TOSHIBA mini flat coupler TLP115A is a small outline coupler, suitable for surface mount assembly.

TLP115A consists of a high output power GaAlAs light emitting diode, optically coupled to an integrated high gain, high speed shielded photo detector whose output is an open collector schottky clamped transistor. The shield, which shunts capacirively coupled common noise to ground, provides a guaranteed transient immunity specification of $1000V/\mu s$.

- Input current thresholds: IF = 5mA (max.)
- Switching speed: 10MBd (typ.)
- Common mode transient immunity: ± 1000V / μs (min.)
- Guaranteed performance over temp. : 0~70°C
- Isolation voltage: 2500Vrms (min.)
- UL recognized: UL1577, file no. E67349

Schematic



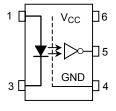
3.6 ± 0.2 3.6 ± 0.2 7.0 ± 0.4

Weight: 0.09 g (typ.)

TOSHIBA

Pin Configuration (top view)

11-4C2



- 1 : Anode
- 3: Cathode
- 4 : GND
- 5 : V_O(Output)
- 6 : V_{CC}

Truth Table (positive logic)

Input	Output
Н	L
L	Н

Note. A 0.1µF bypass capacitor must be connected between pins 4 and 6.

Absolute Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit		
	Forward current	(Note 1)	lF	20	mA	
Ω	Pulse forward current	(Note 2)	I _{FP}	40	mA	
۳	Peak transient forward current	(Note 3)	I _{FPT}	1	Α	
Reverse voltage		V _R	5	V		
	Output current		IO	25	mA	
Detector	Output voltage		Vo	7	V	
Dete	Supply voltage(1 minute maximum)		V _{CC}	7	V	
	Output power dissipation		Ро	40	mW	
Оре	erating temperature range	nperature range		-40~85	°C	
Sto	Storage temperature range		T _{stg}	-55~125	°C	
Lea	Lead solder temperature(10 sec.)		T _{sol}	260	°C	
Isolation voltage(AC, 1 min., RH≤ 60%,		Note 4)	BVS	2500	Vrms	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

(Note 1) Derate 0.36mA / °C above 70°C.

(Note 2) 50% duty cycle, 1ms pulse width. Derate 0.72mA / °C above 70°C.

(Note 3) Pulse width $\leq 1 \mu s$, 300pps.

Recommended Operating Conditions

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Input voltage, low level	V_{FL}	-3	0	1.0	V
Input current, high level	I _{FH}	6.3	8	20	mA
Supply voltage	V _{CC}	4.5	5	5.5	V
Fan out (TTL load, each channel)	N	_	_	8	_
Operating temperature	T _{opr}	0	_	70	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Electrical Characteristics (unless otherwise specified, Ta = 0~70°C, V_{CC} = 4.5 ~ 5.5V, $V_{FL} \le 1.0V$)

Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit	
Forward voltage	V _F	I _F = 10mA, Ta =25°C	1.2	1.4	1.7	V	
Forward voltage temperature coefficient	V _F / Ta	I _F = 10mA	_	-2	_	mV / °C	
Reverse current	I _R	V _R = 3V, Ta = 25°C	_	_	10	μΑ	
Capacitance between terminals	C _T	V _F = 0, f = 1MHz, Ta = 25°C	_	30	_	РF	
High level output voltage	I	V _F = 1.0, V _O = 5.5V	_	_	250	μΑ	
	Іон	V _F = 1.0, V _O = 5.5V, Ta = 25°C	_	0.5	10		
Low level output current	V _{OL}	I _F = 5mA I _{OL} = 13mA (sinking)	_	0.4	0.6	V	
"H level output→L level output" input current	I _{FH}	I _{OL} = 13mA (sinking) V _{OL} = 0.6V	_	_	5	mA	
High level supply current	Icch	V _{CC} = 5.5V, I _F = 0	_	7	15	mA	
Low level supply current	ICCL	V _{CC} = 5.5V, I _F = 10mA	_	12	19	mA	
Input-output insulation leakage current	Is	V _S = 3540V, t = 5s Ta = 25°C (Note 4)	_	_	100	μA	
Isolation resistance	R _S	R.H. ≤ 60%, V _S = 500V DC Ta = 25°C (Note 4)	5×10 ¹⁰	10 ¹⁴	_	Ω	
Stray capacitance between input to output	Cs	V _S = 0, f = 1MHz Ta = 25°C (Note 4)	_	0.8	_	рF	

^{*} All typical values are V_{CC} = 5V, Ta = 25°C.

Switching Characteristics (V_{CC} = 5V, Ta = 25°C)

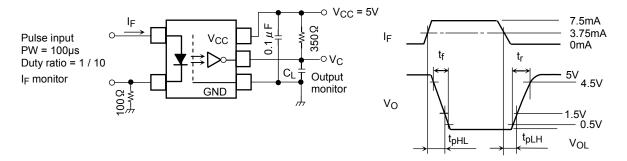
Characteristic	Symbol	Test Cir- cuit	Test Condition	Min.	Тур.	Max.	Unit
Propagation delay time (H→L)	t _{pHL}	1	$I_F = 0 \rightarrow 7.5 \text{mA}$ C _L = 15pF, R _L = 350Ω	_	60	120	ns
Propagation delay time (L→H)	t _{pLH}	1	$I_F = 7.5 \rightarrow 0 \text{mA}$ C _L = 15pF, R _L = 350Ω	-	60	120	ns
Output rise fall time(10–90%)	t _r , t _f	2	$R_L = 350, C_L = 15pF$ $I_F = 0 \leftrightarrow 7.5mA$	-	30	_	ns
Common mode transient immunity at high output level	CM _H	2	$I_F = 0 \text{ mA},$ $V_{CM} = 400V_{p-p}, V_{O(MIN)}=2V$ $R_L = 350\Omega$	1000		_	V / μs
Common mode transient immunity at low output level	CML	2	$I_F = 7.5 \text{ mA}, V_{CM} = 400V_{p-p}$ $V_{O(MAX)} = 0.8V,$ $R_L = 350\Omega$	-1000	_	_	V / µs

- (Note 4) Device considered a two–terminal device: Pins 1 and 3 shorted together, and pins 4, 5 and 6 shorted together.
- (Note 5) The V_{CC} supply voltage to each TLP115A isolator must be bypassed by $0.1\mu F$ capacitor. This can be either a ceramic or solid tantalum capacitor with good high frequency characteristic and should be connected as close as possible to package V_{CC} and GND pins of each device.

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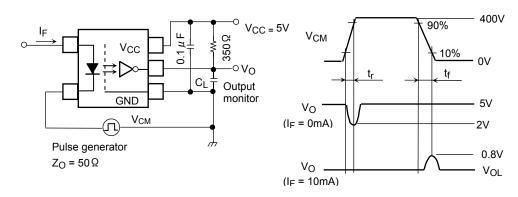
(Note 6) Maximum electrostatic discharge voltage for any pins: 180V(C = 200pF, R = 0)

Test Circuit 1: Switching Time Test Circuit



 C_{L} is approximately 15pF which includes probe and stray wiring capacitance.

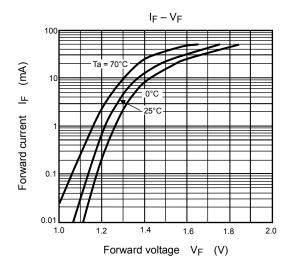
Test Circuit 2: Common Mode Transient Immunity Test Circuit

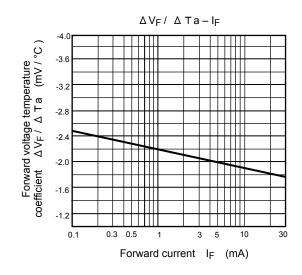


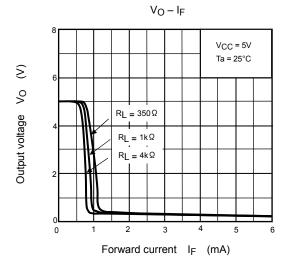
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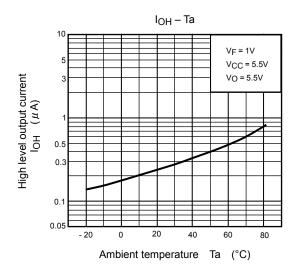
$$CM_{H}=\frac{320~(V)}{t_{\Gamma}(\mu s)},CM_{L}=\frac{320~(V)}{t_{f}(\mu s)}$$

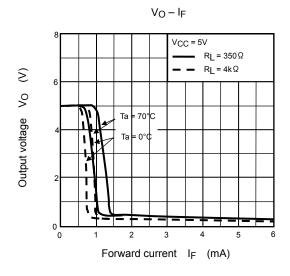
 $C_{\mbox{\scriptsize L}}$ is approximately 15pF which includes probe and stray wiring capacitance.

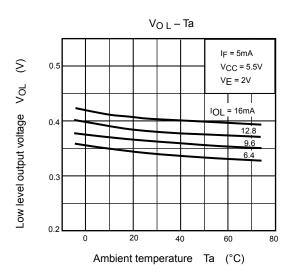


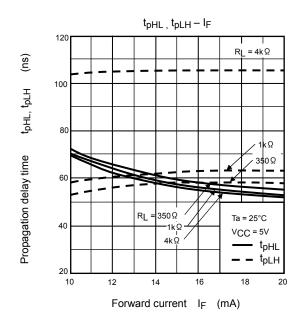


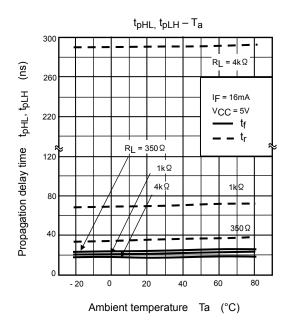


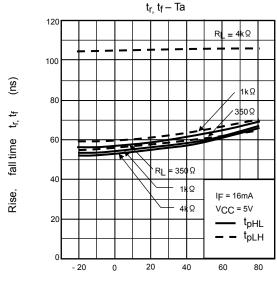












Ambient temperature Ta (°C)

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